Notice of References Cited Application/Control No. 10/808,963 Examiner Kezhen Shen Applicant(s)/Patent Under Reexamination FUKUZAWA ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,063,468	05-2000	Aratani et al.	428/64.1
*	В	US-2003/0138728 A1	07-2003	Saito, Naoki	430/270.15
*	С	US-2004/0157159 A1	08-2004	Zhou et al.	430/270.13
*	D	US-6,071,587	06-2000	Yoshinari et al.	428/64.1
*	E	US-2004/0208107 A1	10-2004	Yamaga et al.	369/094
*	F	US-6,246,656 B1	06-2001.	Kawakubo et al.	369/112.23
*	G	US-2003/0043730 A1	03-2003	Uchiyama et al.	369/275.5
	Н	US-			
	l	US-			
	J	US			
	К	US-			
7-8	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ņ					
	0					
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

-	NOVE ATENT DOCUMENTO							
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	U							
	>							
	W							
	x							

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.